

**Search Notes**

Application/Control No.

10/731,517

Examiner

Eugene Lee

Applicant(s)/Patent under  
Reexamination

JENG, ERIK S.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	324,311	2/14/2007	EL
257	317	2/14/2007	EL
257	e27.078	2/14/2007	EL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	324,311	2/14/2007	EL
257	317	2/14/2007	EL
257	e27.078	2/14/2007	EL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
searched EAST, USPAT, JPO, EPO	2/14/2007	EL